

COM Tool Runtime Assessment Using Local Search and Sample Adjustment

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IEEE 802.3 Channel Operating Margin (COM) Open Source Project Ad Hoc

History

Revision	Date	Comment
0.5	31-May-2026	<ul style="list-style-type: none">Initial Draft.

1. Problem Statement

- How can COM runtime be reduced using Local Search and optimized sample adjustment ranges while maintaining accuracy and robustness?

2. Summary

- Evaluated 171 of the KR and CR channels posted on the 802.3dj Public Area.
 - Total cases= $171 \times 4 = 684$ given two tests for package class A and package class B.
- The Full-Sweep Local Search shows 0.00 dB delta COM compared to the Exhaustive Full Search.
 - One may use Local Search= 2 with TS_SRCH_MODE= full-sweep for 0.00 dB delta COM and noticeable run time reduction compared to Exhaustive Full Search.
- Local Search with TS_SRCH_MODE= middle is not recommended.
 - The Middle Local Search shows a large delta COM (greater than 1 dB) compared to the Exhaustive Full Search.
- sample_adustment= [-32 32] may be recommended.
 - sample_adustment= [-16 16] shows as much as 0.5 dB delta COM compared to sample_adustment= [-32 32].
 - As future work, it is recommended to explore reduced sample_adjustment, such as [-32, 0] or [-24, 0], to further improve runtime efficiency.

3. List of CR and KR Channels on 802.3dj Public Area

Below are the 200 Gb/s CR and KR channel data (TP0 to TP5)- with crosstalk.

1. akinwale_3dj_01_2311: x4
2. weaver_3dj_02_2311: x12
3. akinwale_3dj_01_2310: x7
4. lim_3dj_07_2309: x1
5. lim_3dj_04_230629: x1
6. lim_3dj_03_230629: x1
7. weaver_3dj_elec_01_230622: x8
8. shanbhag_3dj_01_2305: x6
9. shanbhag_3dj_02_2305: x4
10. kocsis_3dj_02_2305: x5
11. weaver_3dj_02_2305: x36
12. mellitz_3dj_02_elec_230504: x27
13. weaver_3dj_02_2303: x5
14. mellitz_3dj_02_2303: x54

Table 178–14—Device termination and package model parameters

Parameter	Symbol	Value	Units
Device termination model			
Single-ended device capacitance for stage 1	$C_d^{(1)}$	40×10^{-6}	nF
Single-ended device capacitance for stage 2	$C_d^{(2)}$	90×10^{-6}	nF
Single-ended device capacitance for stage 3	$C_d^{(3)}$	110×10^{-6}	nF
Single-ended device series inductance for stage 1	$L_s^{(1)}$	0.13	nH
Single-ended device series inductance for stage 2	$L_s^{(2)}$	0.15	nH
Single-ended device series inductance for stage 3	$L_s^{(3)}$	0.14	nH
Single-ended bump capacitance	C_b	30×10^{-6}	nF
Device package model, class A			
Transmission line parameter γ_0	γ_0	5×10^{-4}	1/mm
Transmission line parameter a_1	a_1	8.9×10^{-4}	ns ^{1/2} /mm
Transmission line parameter a_2	a_2	2×10^{-4}	ns/mm
Transmission line parameter r	r	6.141×10^{-3}	ns/mm
Transmission line 1 length, Test 1	$z_p^{(1)}$	33	mm
Transmission line 1 length, Test 2	$z_p^{(1)}$	12	mm
Transmission line 1 characteristic impedance	$Z_c^{(1)}$	87.5	Ω
Transmission line 2 length	$z_p^{(2)}$	1.8	mm
Transmission line 2 characteristic impedance	$Z_c^{(2)}$	92.5	Ω
Device package model, class B			
Transmission line parameter γ_0	γ_0	5×10^{-4}	1/mm
Transmission line parameter a_1	a_1	6.5×10^{-4}	ns ^{1/2} /mm
Transmission line parameter a_2	a_2	2.93×10^{-4}	ns/mm
Transmission line parameter r	r	6.141×10^{-3}	ns/mm
Transmission line 1 length, Test 1, Tx / Rx	$z_p^{(1)}$	45 / 44	mm
Transmission line 1 length, Test 2, Tx / Rx	$z_p^{(1)}$	30 / 29	mm
Transmission line 1 characteristic impedance	$Z_c^{(1)}$	87.5	Ω
Transmission line 2 length	$z_p^{(2)}$	2	mm
Transmission line 2 characteristic impedance	$Z_c^{(2)}$	95	Ω
Transmission line 3 length	$z_p^{(3)}$	1.3	mm
Transmission line 3 characteristic impedance	$Z_c^{(3)}$	100	Ω
Transmission line 4 length	$z_p^{(4)}$	1.5	mm
Transmission line 4 characteristic impedance	$Z_c^{(4)}$	78	Ω

■ Total of 171 channels from the IEEE 802.3dj Public Area are evaluated against the class A and class B package models.
 □ Total cases= 171x4= 684 cases.

1. Local Search and TS_SRCH_MODE

A. COM Spreadsheet: Local Search and TS_SRCH_MODE

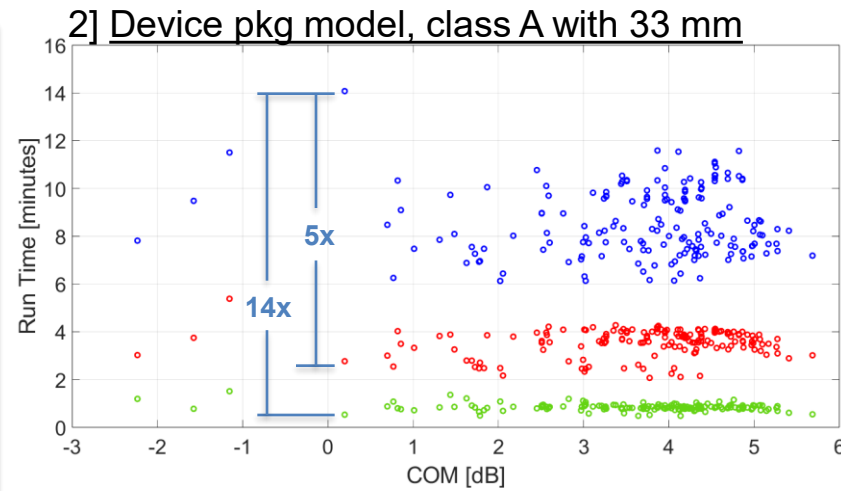
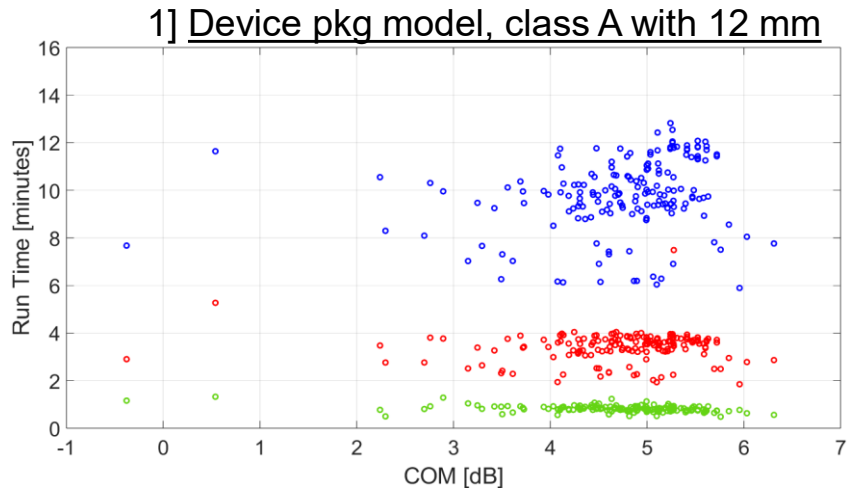
<u>Name</u>	<u>Local Search</u>	<u>TS_SRCH_MODE</u>
Exhaustive Full Search	0	Do Not Care
Full-Sweep Local Search	2	full-sweep
Middle Local Search	2	middle

Example,

ts_anchor	1
sample_adjustment	[-32 32]
Local Search	0
TS_SRCH_MODE	full-sweep

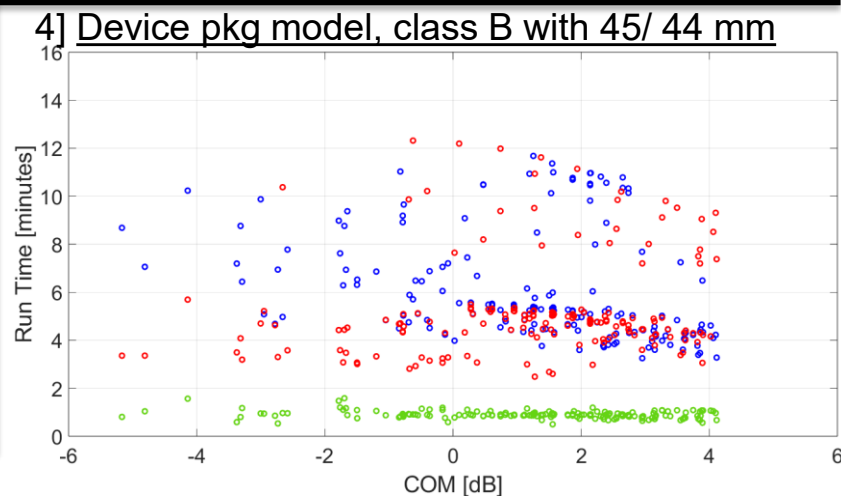
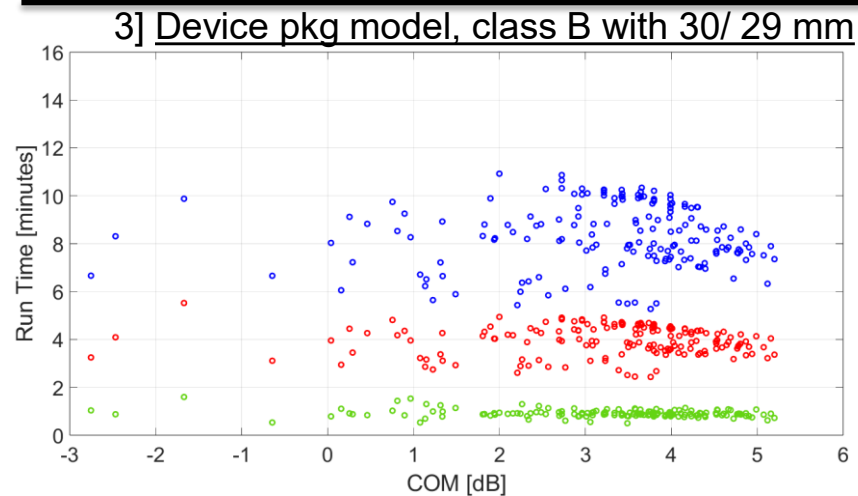
- As an alternative to exhaustive full search for runtime reduction, local search methods can be used.
 - Local search is triggered by setting Local Search to a non-zero value.
 - Local search operates using TS_SRCH_MODE, which can be either full-sweep or middle.
 - ❑ Take the example where sample_adustment= [-32 +32].
 - ❑ Full-sweep: evaluates sample offsets in a fixed linear order across the entire range, e.g., [-32, -31, ..., 0, ..., +31, +32], ensuring exhaustive coverage.
 - ❑ Middle: performs a center-out local search, e.g., [0, -1, +1, -2, +2,, -32, +32], and typically terminates early when the FOM degrades, so it may not reach the full range (± 32).

B. Results on Run Time



Exhaustive Full Search
Full-Sweep Local Search
Middle Local Search

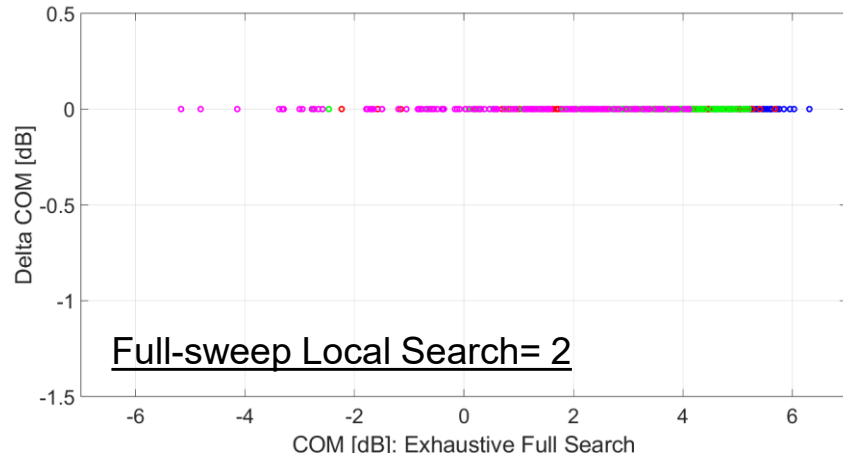
Note. Local Search= 2 for Full-Sweep Local Search and Middle Local Search.



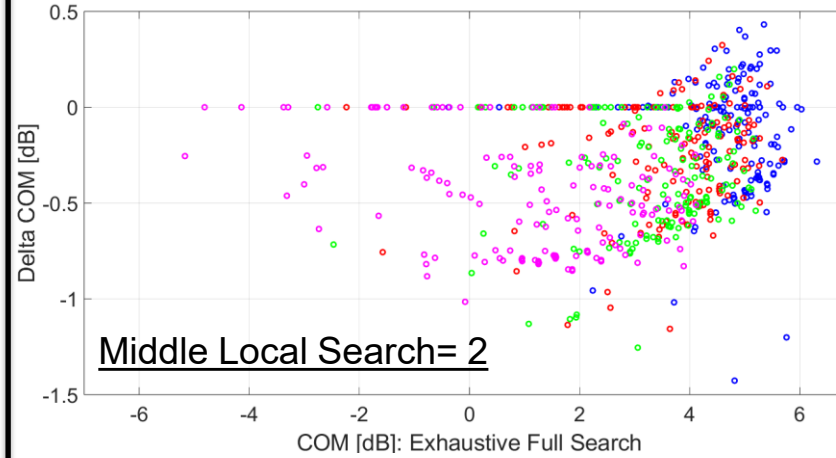
- The Full-Sweep Local Search achieves a 5x reduction in runtime compared to the Exhaustive Full Search.
- The Middle Local Search achieves a 14x reduction in runtime compared to the Exhaustive Full Search.

C. Results on COM: Page 1

1] Full-Sweep Local Search -Exhaustive Full Search



2] Middle Local Search -Exhaustive Full Search

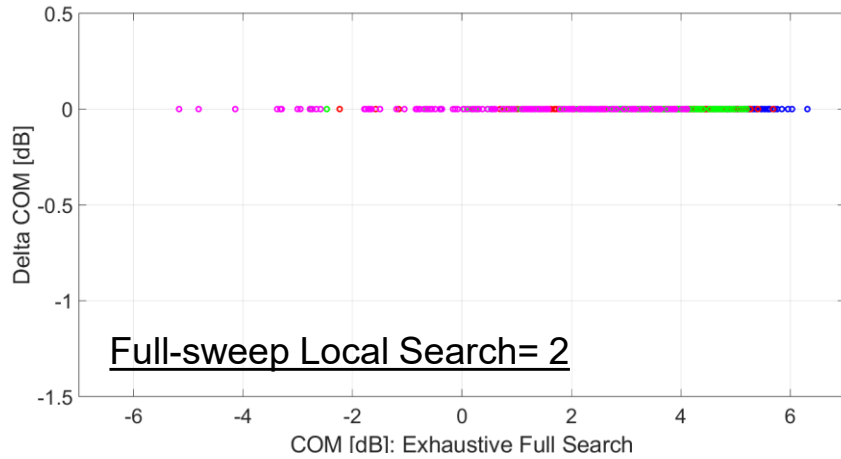


Device pkg model, class A with 12 mm
Device pkg model, class A with 33 mm
Device pkg model, class B with 30/ 29 mm
Device pkg model, class B with 45/ 44 mm

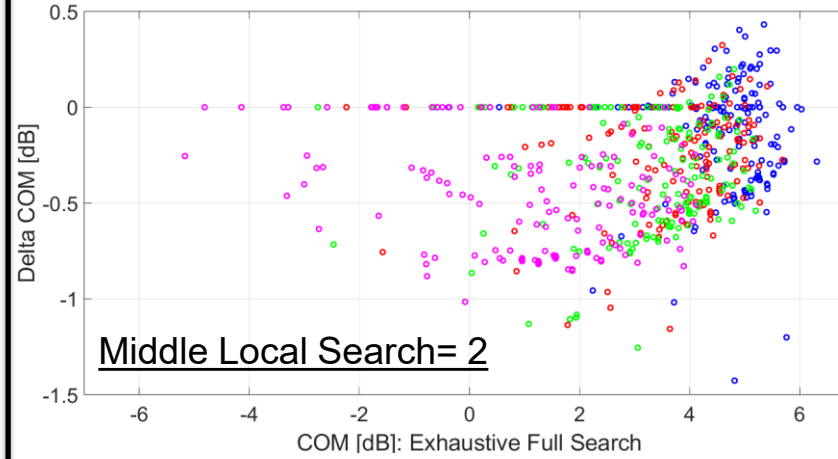
- The Full-Sweep Local Search shows 0.00 dB delta COM compared to the Exhaustive Full Search.
- The Middle Local Search shows a large delta COM (greater than 1 dB) compared to the Exhaustive Full Search.

C. Results on COM: Page 2

1] Full-Sweep Local Search -Exhaustive Full Search

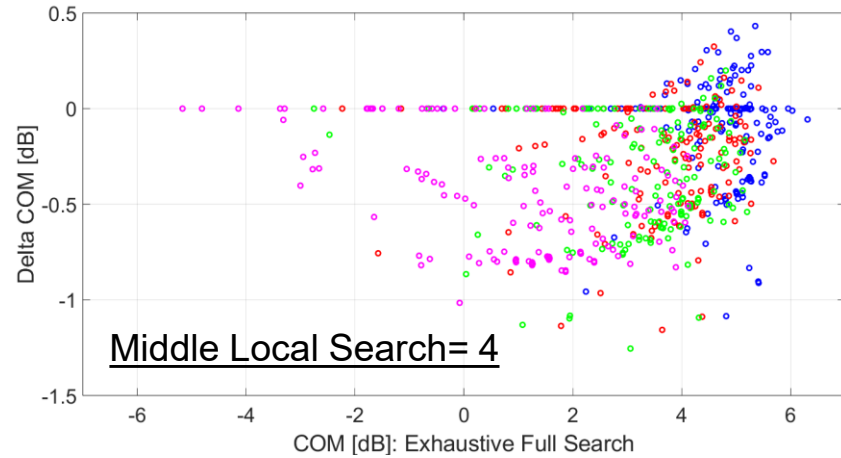


2] A. Middle Local Search -Exhaustive Full Search

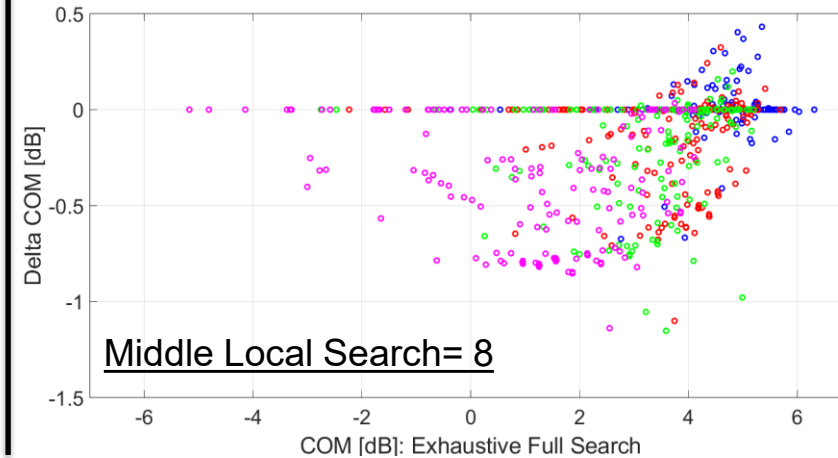


Device pkg model, class A with 12 mm
Device pkg model, class A with 33 mm
Device pkg model, class B with 30/ 29 mm
Device pkg model, class B with 45/ 44 mm

2] B. Middle Local Search -Exhaustive Full Search



2] C. Middle Local Search -Exhaustive Full Search



- The Middle Local Search may not be recommended.

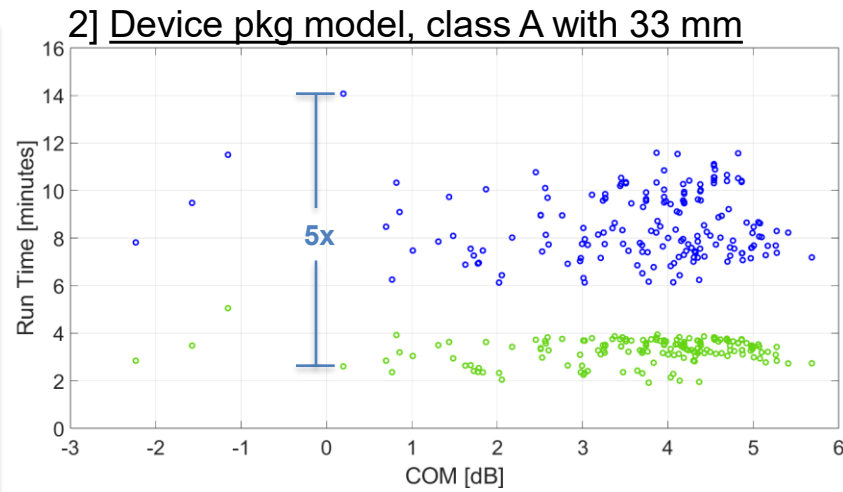
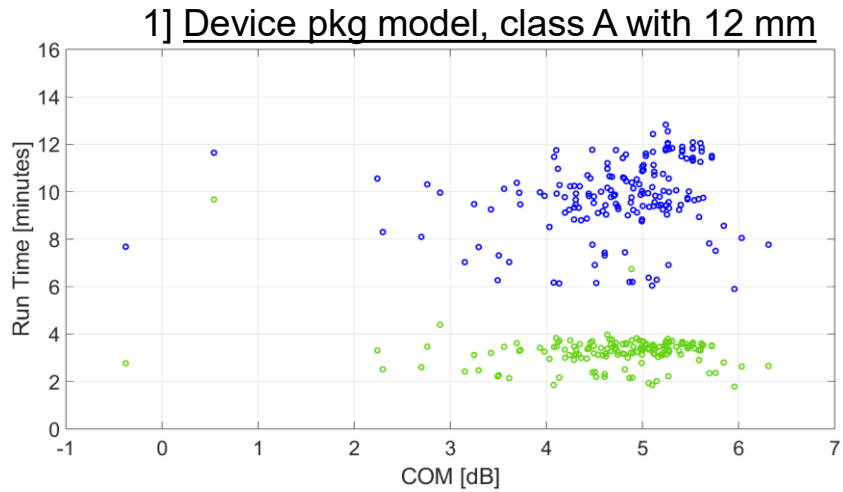
2. sample_adjustment

A. COM Spreadsheet: sample_adjustment

I	J	K	L	M
	Operational			
	ERL Pass threshold	11	dB	
	COM Pass threshold	3	db	
	DER_0	2.00E-04		
	T_r	0.00400	ns	
	FORCE_TR	1	logical	for legacy but require
	PMD_type	C2C	for MMSE use C2C only	
	EW	1		
	MLSE	1	logical	
	ts_anchor	1		
	sample_adjustment	[-32 32]		
	Local Search	0		
	flim	6.70E+10	Hz	
	zero_pad	1	logical	
	Filter: Rx FFF			

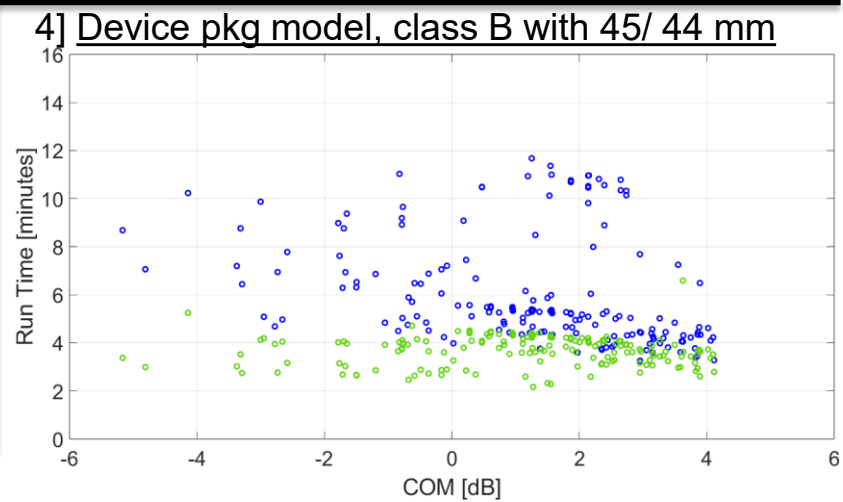
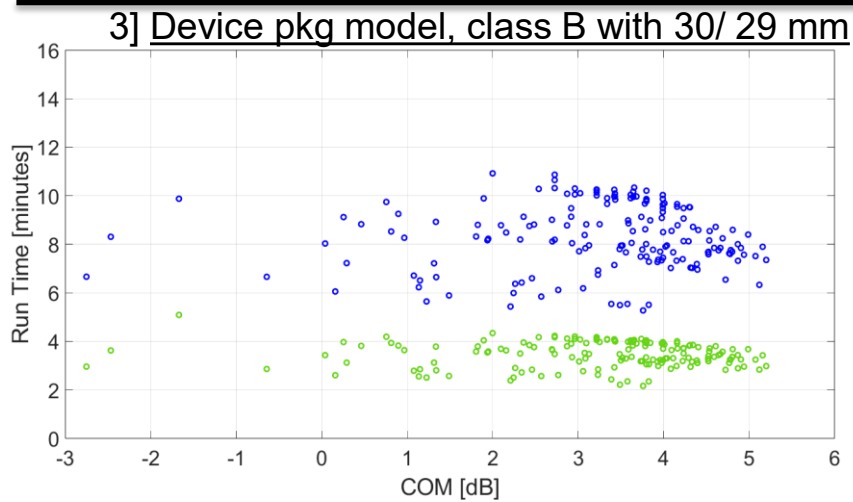
- Sample adjustment is the discrete time shift of the sampling point (relative to the cursor) that is swept to find the optimal sampling location for maximum FOM.

B. Results on Run Time



Exhaustive Full Search with
sample_adustment= [-32 32]

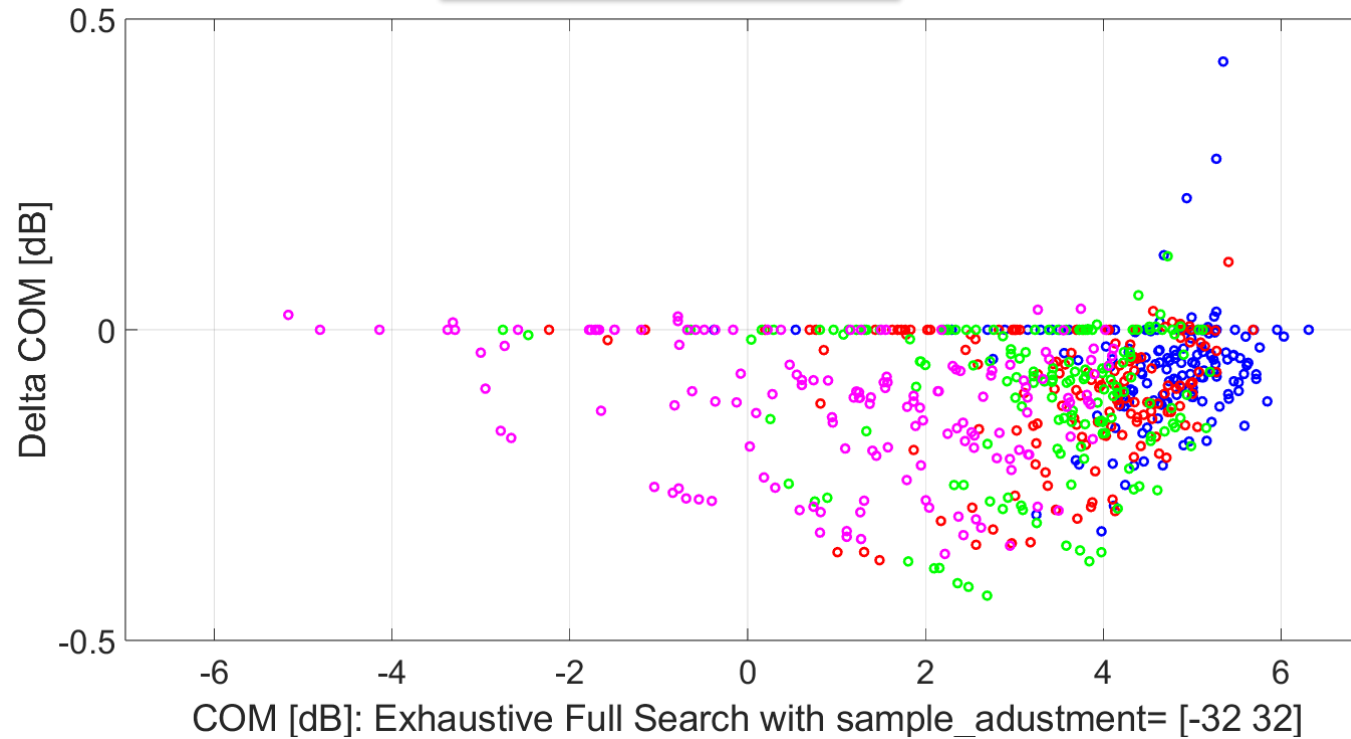
Exhaustive Full Search with
sample_adustment= [-16 16]



- A noticeable reduction in run time is observed in using sample_adustment= [-16 16] when compared to sample_adustment of [-32 32].

C. Results on COM

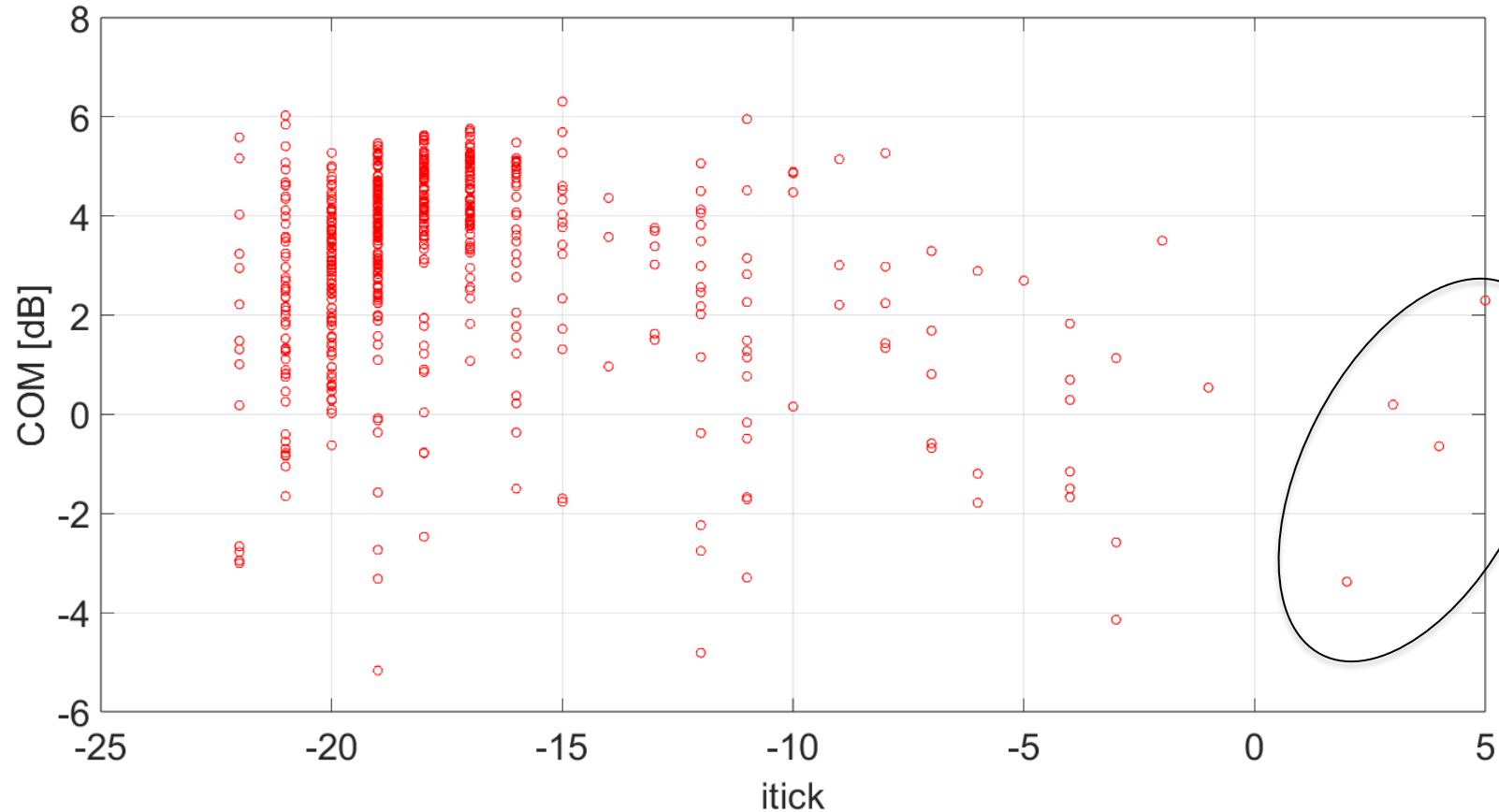
Exhaustive Full Search with sample_adustment= [-16 16] - sample_adustment= [-32 32]



- Device pkg model, class A with 12 mm
- Device pkg model, class A with 33 mm
- Device pkg model, class B with 30/ 29 mm
- Device pkg model, class B with 45/ 44 mm

▪ sample_adustment= [-16 16] shows as much as 0.5 dB delta COM compared to sample_adustment= [-32 32].

D. Results on itick



Same channel
- Two tests
for package
class A and
package
class B.

- The itick values predominantly lie within the range of 0 to -24.
- A single channel appears as an outlier, exhibiting a positive itick value.
- As future work, it is recommended to explore reduced sample_adjustment, such as [-32, 0] or [-24, 0], to further improve runtime efficiency.

Thank you

COM Spreadsheet for Package Class A

data rate, die load, ref impedance				I/O control			Operational			SAVE_CONFIG2MAT	0			
Parameter	Setting	Units	Information	DIAGNOSTICS	1	logical	ERL Pass threshold	11	dB	Receiver testing				
f_b	106.25	Gbd		DISPLAY_WINDOW	1	logical	COM Pass threshold	3	db	RX_CALIBRATION				
f_min	0.05	GHz		CSV_REPORT	0	logical	DER_0	2.00E-04		0				
Delta_f	0.01	GHz		RESULT_DIR	.\results\CAKR_{date}\		T_r	0.00400	ns	Sigma BBN step				
C_d	[0.4e-4 0.9e-4 1.1e-4; 0.4e-4 0.9e-4 1.1e-4]	nF	[TX RX]	SAVE_FIGURES	0	logical	FORCE_TR	1	logical	5.00E-03				
L_s	[0.13 0.15 0.14; 0.13 0.15 0.14]	nH	[TX RX]	Port Order	[1 3 2 4]		PMD_type	C2C	for legacy but required		ICN parameters			
C_b	[0.3e-4 0.3e-4]	nF	[TX RX]	RUNTAG	KR_pkgA		EW	1		T_t	6.000	ps		
R_0	46.25	Ohm		COM_CONTRIBUTION	0	logical	MLSE	1	logical	f_v	0.371	39.42		
PKG_NAME	PKG_LowR_CLASSA	PKG_LowR_CLASSA	TX RX	TDR and ERL options			sample_adjustment	[-32 32]		T_ft	4.250	ps		
z_p select	[1 2]			TDR	1	logical	Local Search	0		T_nt	4.250	ps		
L	4			ERL	1	logical	flim	6.70E+10	Hz	f_f	0.524	55.65		
M	32			ERL_ONLY	0	ns	zero_pad	1	logical	f_n	0.524	55.65		
filter and Eq				TR_TDR	0.005		Filter: Rx FFE					f_1	0.010	GHz
f_r	0.55	*fb		N	7000	logical	ffe_pre_tap_len	6	UI	d_w				
c(0)	0.55		min	TDR_Butterworth	1		ffe_post_tap_len	8	UI	N_fix-d_w				
c(-1)	0		[-0.34; 02:0] [min:step:max]	beta_x	0		ffe_pre_tap1_max	0.7	(normalized)	w_max(d_w) and -w_min(d_w)				
c(-2)	0		[0.14; 02:0] [min:step:max]	rho_x	0.618		ffe_post_tap1_max	0.7	(normalized)	w_max(d_w+2) and -w_min(d_w+2)				
c(-3)	0		[min:step:max]	TDR_W_TXPKG	0	UI	ffe_tapn_max	0.7	(normalized)	all other fixed w_max and w_min				
c(-4)	0		[min:step:max]	N_bx	16	??	num_ui_RXFF_noise	4096						
c(1)	0		[-0.2; 02:0] [min:step:max]	fixture delay time	[00]		Floating Tap Control					A_ft	0.600	V
N_b	1	UI		Tukey_Window	1		N_bg	2	0 1 2 or 3 groups	N_wg				
b_max(1)	0.85	As/dffe1		Z_t	46.25		N_bf	4	taps per group	N_wf				
b_max(2..N_b)	0	not used		Noise, jitter			N_f	80	UI span for floating taps	Nmax-d_w-1				
b_min(1)	0	As/dffe1		sigma_RJ	0.01	UI	bmaxg	0.05	max FFE value for floating taps	all floating w_max and w_min				
b_min(2..N_b)	0	not used		A_DD	0.02	V^2/GHz	N_tail_start	9	(UI) start of tail taps limit	not supposed to be used but untested				
g_DC	[-20:1:0]	dB	[min:step:max]	eta_0	7.50E-09	dB	TS_SRCH_MODE	full-sweep						
f_z	42.50	GHz		SNR_TX	33.5									
f_p1	42.50	GHz		R_LM	0.95									
f_p2	106.25	GHz		N_qb	6									
g_DC_HP	[-6:1:0]		[min:step:max]	P_qc	1.00E-07									
f_HP_PZ	1.328125	GHz												

Parameter	Setting	Units	Information
board_tl_gamma0_a1_a2	[0.5.95e-4 2.6e-05]		1.4 db/in @ 53.125G
board_tl_tau	5.790E-03		ns/mm
board_Z_c	92.5		Ohm
z_bp (TX)	9		mm
z_bp (NEXT)	9		mm
z_bp (FEXT)	9		mm
z_bp (RX)	9		mm
C_0	[00]		nF
C_1	[00]		nF
Include PCB	0		logical

Parameter	Setting	Units	Information
package_tl_gamma0_a1_a2	[0.0005 0.00089 0.0002]		
package_tl_tau	0.006141	ns/mm	
package_Z_c	[87.5 87.5 ; 95 95 ; 100 100; 100 100]	Ohm	
R_d	[46.25 46.25]	Ohm	[TX RX]
z_p (TX)	[12 33 33 33 ; 1.8 1.8 1.8 1.8 ; 0 0 0 0 ; 0 0 0 0]	mm	[test cases]
z_p (NEXT)	[12 33 33 33 ; 1.8 1.8 1.8 1.8 ; 0 0 0 0 ; 0 0 0 0]	mm	[test cases]
z_p (FEXT)	[12 33 33 33 ; 1.8 1.8 1.8 1.8 ; 0 0 0 0 ; 0 0 0 0]	mm	[test cases]
z_p (RX)	[12 33 33 33 ; 1.8 1.8 1.8 1.8 ; 0 0 0 0 ; 0 0 0 0]	mm	[test cases]
C_p	[0.4e-4 0.4e-4]	nF	[TX RX]
A_v	0.385	V	Vf=0.400
A_fe	0.385	V	Vf=0.399
A_ne	0.481	V	Vf=0.400
.END			

